



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017
& ANSI/NCSL Z540-1-1994

TRESCAL, INC.
6540 Emmaus Church Road Suite 106
Providence Forge, VA 23140
Rob Igoe Phone: 336 725 6120

CALIBRATION

Valid To: April 30, 2024

Certificate Number: 1486.02

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations^{1, 7}:

I. Dimensional

Parameter/Equipment	Range	CMC ^{2, 5} (±)	Comments
Micrometers ³	Up to 12 in	(190 + 40L) µin	Grade 0 gage blocks
Calipers ³ – Outer Diameter, Inner Diameter, Depth	Up to 12 in	(200 + 50L) µin	Grade 0 gage blocks
Dial Indicators ³	(0.001 to 1) in	330 µin	Grade 0 gage blocks

II. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
DC Voltage – Generate ³	(0 to 330) mV 330 mV to 3.3 V (3.3 to 33) V (33 to 330) V (330 to 1000) V	0.8 µV + 16 nV/mV 17 µV + 5 µV/V 88 µV + 7 µV/V 0.56 mV + 14 µV/V 2.7 mV + 14 µV/V	Fluke 5522A

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
DC Voltage – Measure ³	Up to 100 mV (0.1 to 1) V (1 to 10) V (10 to 100) V (100 to 1000) V (1 to 40) kV	0.33 μ V + 17 μ V/V 0.52 μ V + 8 μ V/V 8.8 μ V + 8.1 μ V/V 35 μ V + 10 μ V/V 0.2 mV + 12 μ V/V 2.3 % + 10 V	HP 3458A Fluke 80KV-40 probe & HP 3458A
DC Current – Generate ³	Up to 330 μ A 330 μ A to 3.3 mA (3.3 to 33) mA (33 to 330) mA 330 mA to 1.1 A (1.1 to 3) A (3 to 11) A (11 to 20.5) A (20.5 to 105) A (105 to 200) A (16 to 160) A (160 to 525) A (525 to 1000) A	16 nA + 0.12 nA/ μ A 41 nA + 80 nA/mA 0.21 μ A + 80 nA/mA 2.1 μ A + 80 nA/mA 33 μ A + 0.16 mA/A 0.37 mA + 0.13 mA/A 0.49 mA + 0.39 mA/A 9.4 mA + 0.8 mA/A 0.063 % + 9.4 mA 0.063 % + 45 mA 0.07 % + 5.9 mA 0.058 % + 47 mA 0.058 % + 0.23 A	Fluke 5522A Fluke 5522A w/ 10 coil
DC Current – Measure ³	(0 to 100) nA (0.1 to 1) μ A (1 to 10) μ A (10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	41 pA + 89 μ A/A 41 pA + 24 pA/ μ A 40 pA + 24 pA/uA 82 pA + 22 pA/uA 6 nA + 24 nA/mA 53 nA + 21 nA/mA 0.53 μ A + 37 nA/mA 10 μ A + 0.11 mA/A	HP 3458A
Capacitance – Generate ³	(0.19 to 0.3999) nF (0.4 to 1.0999) nF (1.1 to 3.2999) nF (3.3 to 10.9999) nF (11 to 32.9999) nF (33 to 109.999) nF (110 to 329.999) nF (0.33 to 1.099 99) μ F (1.1 to 3.299 99) μ F (3.3 to 10.9999) μ F (11 to 32.9999) μ F (33 to 109.999) μ F (110 to 329.999) μ F (0.33 to 1.099 99) mF (1.1 to 3.299 99) mF (3.3 to 10.9999) mF (11 to 32.9999) mF	9 pF + 4 pF/nF 10 pF + 4 pF/nF 13 pF + 4 pF/nF 15 pF + 2 pF/nF 0.1 nF + 2 pF/nF 0.15 nF + 2 pF/nF 0.5 nF + 2 pF/nF 1.5 nF + 2 nF/ μ F 5 nF + 2 nF/ μ F 14 nF + 2 nF/ μ F 60 nF + 3 nF/ μ F 0.2 μ F + 4 nF/ μ F 0.63 μ F + 4 nF/ μ F 2 μ F + 4 μ F/mF 7 μ F + 4 μ F/mF 38 μ F + 2.5 μ F/mF 90 μ F + 6 μ F/mF	Fluke 5522A

Parameter/Equipment	Range	CMC ^{2, 4} (±)	Comments
DC Resistance – Generate ³	(0 to 10.9999) Ω (11 to 32.9999) Ω (33 to 109.9999) Ω (110 to 329.9999) Ω (330 to 1099.999) Ω (1.1 to 3.299 999) kΩ (33 to 10.999 99) kΩ (1 to 32.999 99) kΩ (33 to 109.999) kΩ	1.2 mΩ + 24 μΩ/Ω 1.5 mΩ + 24 μΩ/Ω 1.9 mΩ + 22 μΩ/Ω 4.1 mΩ + 22 μΩ/Ω 9.1 mΩ + 22 μΩ/Ω 41 mΩ + 22 μΩ/Ω 92 mΩ + 22 μΩ/Ω 0.41 Ω + 22 μΩ/Ω 0.9 Ω + 22 μΩ/Ω	Fluke 5522A, 4-wire
	(110 to 329.999) kΩ (0.33 to 1.099 99) MΩ (1.1 to 3.299 00) MΩ (3.3 to 10.9999) MΩ (11 to 32.9999) MΩ (33 to 109.9999) MΩ (110 to 329.9999) MΩ (330 to 1100) MΩ	8.4 Ω + 26 μΩ/Ω 14 Ω + 26 μΩ/Ω 93 Ω + 48 μΩ/Ω 0.4 kΩ + 0.1 mΩ/Ω 4.4 kΩ + 0.2 mΩ/Ω 16 kΩ + 0.4 mΩ/Ω 0.35 MΩ + 2.4 mΩ/Ω 4.4 MΩ + 12 mΩ/Ω	Fluke 5522A, 2-wire
Resistance – Measure ³	(0 to 10) Ω (10 to 100) Ω (0.1 to 1) kΩ (1 to 10) kΩ (10 to 100) kΩ (0.1 to 1) MΩ (1 to 10) MΩ (10 to 100) MΩ (0.1 to 1) GΩ	55 μΩ + 15 μΩ/Ω 0.52 mΩ + 13 μΩ/Ω 0.53 mΩ + 10 μΩ/Ω 5.3 mΩ + 10 μΩ/Ω 53 mΩ + 11 μΩ/Ω 2.3 Ω + 17 μΩ/Ω 0.1 kΩ + 55 μΩ/Ω 1 kΩ + 0.52 mΩ/Ω 10 kΩ + 5.1 mΩ/Ω	HP 3458A, 4-wire
Electrical Calibration of RTD Indicators ³ –			
Pt 385, 100 Ω	(-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C (630 to 800) °C	0.042 °C 0.041 °C 0.057 °C 0.073 °C 0.081 °C 0.097 °C 0.19 °C	Fluke 5522A
Pt 385, Pt 392, 100 Ω	(-200 to 800) °C	0.52 °C	Fluke 741B
Pt 3926, 100 Ω	(-190 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C	0.041 °C 0.041 °C 0.057 °C 0.073 °C 0.081 °C 0.097 °C	Fluke 5522A
Pt 3916, 100 Ω	(-190 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C	0.033 °C 0.042 °C 0.049 °C 0.065 °C 0.073 °C 0.19 °C	

Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Calibration of RTD Indicators ³ (cont) –			
Pt 385, 200 Ω	(-200 to 0) °C (> 0 to 100) °C (> 100 to 260) °C (> 260 to 300) °C (> 300 to 400) °C (> 400 to 600) °C (> 600 to 630) °C	0.034 °C 0.033 °C 0.042 °C 0.097 °C 0.11 °C 0.11 °C 0.13 °C	Fluke 5522A
Pt 385, 500 Ω	(-200 to -80) °C (> -80 to 100) °C (> 100 to 260) °C (> 260 to 400) °C (> 400 to 600) °C (> 600 to 630) °C	0.034 °C 0.042 °C 0.05 °C 0.065 °C 0.073 °C 0.089 °C	
Pt 385, 1 kΩ	(-200 to 0) °C (> 0 to 100) °C (> 100 to 260) °C (> 260 to 300) °C (> 300 to 600) °C (> 600 to 630) °C	0.026 °C 0.033 °C 0.042 °C 0.049 °C 0.057 °C 0.19 °C	
PtNi 385, 120 Ω	(-80 to 100) °C (> 100 to 260) °C	0.066 °C 0.11 °C	
Cu427. 10 Ω	(-100 to 260) °C	0.24 °C	
Electrical Calibration of Thermocouple Indicators –			
Type E	(-200 to -100) °C (-100 to -25) °C (-25 to 350) °C (350 to 650) °C (650 to 1000) °C	0.4 °C 0.13 °C 0.11 °C 0.13 °C 0.17 °C	Fluke 5522A
Field Calibration ³	(-250 to 1000) °C	0.75 °C	Fluke 741B
Type J	(-210 to -100) °C (-100 to -30) °C (-30 to 150) °C (150 to 760) °C (760 to 1200) °C	0.22 °C 0.13 °C 0.11 °C 0.14 °C 0.18 °C	Fluke 5522A
Field Calibration ³	(-210 to 1200) °C	0.46 °C	Fluke 741B
Type K	(-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 1000) °C (1000 to 1372) °C	0.27 °C 0.14 °C 0.13 °C 0.21 °C 0.32 °C	Fluke 5522A
Field Calibration ³	(-200 to 1372) °C	0.56 °C	Fluke 741B

Parameter/Equipment	Range	CMC ² (±)	Comments
Electrical Calibration of Thermocouple Indicators ³ – (cont)			
Type T	(-250 to -150) °C (-150 to 0) °C (0 to 120) °C (120 to 400) °C	0.51 °C 0.21 °C 0.15 °C 0.13 °C	Fluke 5522A
Field Calibration ³	(-250 to 400) °C	1.1 °C	Fluke 741B

Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comments
AC Voltage – Generate ³			
(1 to 33) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 200) kHz (200 to 500) kHz	5.5 µV + 0.64 µV/mV 5 µV + 0.12 µV/mV 5 µV + 0.16 µV/mV 5.6 µV + 0.8 µV/mV 12 µV + 2.8 µV/mV 47 µV + 6.4 µV/mV 47 µV + 6.4 µV/mV	Fluke 5522A
(33 to 330) mV	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 200) kHz (200 to 500) kHz	14 µV + 0.24 µV/mV 24 µV + 87 nV/mV 11 µV + 0.13 µV/mV 35 µV + 0.28 µV/mV 47 µV + 0.64 µV/mV 0.11 mV + 1.6 µV/mV 0.11 mV + 1.6 µV/mV	
330 mV to 3.3 V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 200) kHz (200 to 500) kHz	0.12 mV + 0.24 mV/V 88 µV + 0.12 mV/V 99 µV + 0.15 mV/V 0.12 mV + 0.24 mV/V 0.29 mV + 0.56 mV/V 1.1 mV + 1.9 mV/V 1.1 mV + 1.9 mV/V	
(3.3 to 33) V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz	1.3 mV + 0.24 mV/V 0.94 mV + 0.12 mV/V 1.6 mV + 0.18 mV/V 1.4 mV + 0.28 mV/V 3.7 mV + 0.72 mV/V	
(33 to 330) V	(10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz	6.8 mV + 0.15 mV/V 10 mV + 0.16 mV/V 12 mV + 0.2 mV/V 13 mV + 0.24 mV/V 93 mV + 1.6 mV/V	
(330 to 1020) V	45 Hz to 10 kHz	88 mV + 0.24 mV/V	

Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comments
AC Voltage – Measure ³			
(1 to 10) mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz	6.1 µV + 0.0003 mV/mV 4.1 µV + 0.0002 mV/mV 4.2 µV + 0.0003 mV/mV 4.9 µV + 0.001 mV/mV 9 µV + 0.005 mV/mV 45 µV + 0.04 mV/mV	HP 3458A, synchronous sub-sampled mode
(10 to 100) mV	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz	12 µV + 0.000 07 mV/mV 2.7 µV + 0.000 07 mV/mV 11 µV + 0.000 14 mV/mV 12 µV + 0.0003 mV/mV 17 µV + 0.0008 mV/mV 47 µV + 0.003 mV/mV 0.12 mV + 0.01 mV/mV 3.8 mV + 0.02 mV/mV	
100 mV to 1 V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz	0.12 mV + 0.000 07 V/V 0.1 mV + 0.000 07 V/V 0.11 mV + 0.000 14 V/V 0.12 mV + 0.0003 V/V 0.17 mV + 0.0008 V/V 0.47 mV + 0.003 V/V 1.2 mV + 0.01 V/V 38 mV + 0.015 V/V	
(1 to 10) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 2) MHz	1.2 mV + 0.000 07 V/V 1 mV + 0.000 07 V/V 1 mV + 0.000 14 V/V 1.2 mV + 0.0003 V/V 1.7 mV + 0.0008 V/V 4.7 mV + 0.003 V/V 12 mV + 0.01 V/V 0.38 V + 0.015 V/V	
(10 to 100) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (0.3 to 1) MHz	13 mV + 0.0002 V/V 11 mV + 0.0002 V/V 11 mV + 0.0002 V/V 13 mV + 0.0004 V/V 21 mV + 0.001 V/V 57 mV + 0.004 V/V 0.17 V + 0.015 V/V	
(100 to 1000) V	(1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	99 mV + 0.0004 V/V 85 mV + 0.0004 V/V 98 mV + 0.0006 V/V 0.14 V + 0.0012 V/V 0.27 V + 0.003 V/V	
(1 to 40) kV	60 Hz	6.0 % + 10 V	Fluke 80KV-40 probe & HP 3458A

Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comments
AC Current – Generate ³			
(29 to 330) µA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.13 µA + 1.6 nA/µA 0.12 µA + 1.2 nA/µA 0.11 µA + 1 nA/µA 0.19 µA + 2.4 nA/µA 0.35 µA + 6.4 nA/µA 0.70 µA + 13 nA/µA	Fluke 5522A
330 µA to 3.3 mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	0.65 µA + 1.6 µA/mA 0.45 µA + 1 µA/mA 0.39 µA + 0.8 µA/mA 0.69 µA + 1.6 µA/mA 2.9 µA + 1.6 µA/mA 3.4 µA + 8 µA/mA	
(3.3 to 33) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	6.4 µA + 1.4 µA/mA 4 µA + 0.72 µA/mA 2.7 µA + 0.32 µA/mA 3.7 µA + 0.64 µA/mA 7.7 µA + 1.6 µA/mA 14 µA + 3.2 µA/mA	
(33 mA to 330) mA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz	65 µA + 1.4 µA/mA 42 µA + 0.72 µA/mA 29 µA + 0.31 µA/mA 68 µA + 0.8 µA/mA 0.13 mA + 1.6 µA/mA 0.27 mA + 3.2 µA/mA	
330 mA to 1.1 A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.56 mA + 1.4 mA/A 0.22 mA + 0.4 mA/A 2.4 mA + 4.8 mA/A 11 mA + 20 mA/A	
(1.1 to 3) A	(10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	1.7 mA + 1.4 mA/A 0.61 mA + 0.48 mA/A 6.1 mA + 4.8 mA/A 26 mA + 20 mA/A	
(3 to 11) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	3.1 mA + 0.48 mA/A 4 mA + 0.8 mA/A 74 mA + 24 mA/A	
(11 to 20.5) A	(45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	15 mA + 0.96 mA/A 17 mA + 1.2 mA/A 0.27 A + 24 mA/A	
AC Current – Measure ³			
Up to 100 µA	(10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz	57 nA + 4 nA/uA 45 nA + 1.5 nA/uA 40 nA + 0.64 nA/uA	HP 3458A

Parameter/Range	Frequency	CMC ^{2, 4} (±)	Comments
AC Current – Measure ³ (cont)			
100 µA to 1 mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz (0.1 to 5) kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.43 µA + 0.0041 mA/mA 0.31 µA + 0.0016 mA/mA 0.26 µA + 0.000 67 mA/mA 0.25 µA + 0.000 37 mA/mA 0.26 µA + 0.000 67 mA/mA 0.63 µA + 0.0042 mA/mA 1.8 µA + 0.0056 mA/mA	HP 3458A
(1 to 10) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz (0.1 to 5) kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	2.4 µA + 0.0041 mA/mA 2.3 µA + 0.0016 mA/mA 2.3 µA + 0.000 67 mA/mA 2.3 µA + 0.000 37 mA/mA 2.3 µA + 0.000 67 mA/mA 4.5 µA + 0.0041 mA/mA 16 µA + 0.0056 mA/mA	
(10 to 100) mA	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz (0.1 to 5) kHz (5 to 20) kHz (20 to 50) kHz (50 to 100) kHz	2.4 µA + 0.0041 mA/mA 2.3 µA + 0.0016 mA/mA 2.3 µA + 0.000 67 mA/mA 2.3 µA + 0.000 37 mA/mA 2.3 µA + 0.000 67 mA/mA 4.5 µA + 0.0041 mA/mA 16 µA + 0.0056 mA/mA	
(0.1 to 1) A	(10 to 20) Hz (20 to 45) Hz (45 to 100) Hz (0.1 to 5) kHz (5 to 20) kHz (20 to 50) kHz	0.42 mA + 0.0041 A/A 0.3 mA + 0.0017 A/A 0.26 mA + 0.0009 A/A 0.27 mA + 0.0011 A/A 0.37 mA + 0.0031 A/A 0.92 mA + 0.01 A/A	
Oscilloscopes ³ –			
DC 50 Ω 1 MΩ	± (0 to 6.6) V ± (0 to 130) V	0.26 % + 40 µv 33 µV + 0.39 mV/V	Fluke 5522A
Square Wave 50 Ω 1 MΩ	1 mV to 6 V _{p-p} 1 mV to 130 V _{p-p} 10 Hz to 1 kHz (1 to 100) kHz	91 µV + 4.3 mV/V 0.2 mV + 0.8 mV/V 0.24 mV + 2 mV/V	
Edge Into 50 Ω	(200 to 300) ps (100 kHz to 2 MHz) (200 to 350) ps (2 to 10) MHz	82 ps 82 ps	

Parameter/Range	Frequency	CMC ^{2, 4, 5} (±)	Comments
Oscilloscopes ³ – (cont.)			
Leveled Sine Wave	5 mV to 5.5 V 50 kHz (reference) 50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz	0.33 mV + 17 mV/V 0.4 mV + 31 mV/V 0.43 mV + 36 mV/V 0.53 mV + 57 mV/V	Fluke 5522A
Time Marker	4 mV to 3.5 V (600 to 1100) MHz 5 s to 50 ms 50 ms to 1 ns	0.58 mV + 67 mV/V 0.0021 % + $t \times 0.1$ % 0.000 36 %	t = time in seconds
Wave Generator	1.8 mV to 2.8 V _{p-p} (50 Ω) 10 Hz to 100 kHz 1.8 mV to 55 V _{p-p} (1 MΩ) 10 Hz to 100 kHz	0.12 mV + 23 mV/V 0.12 mV + 23 mV/V	

III. Fluid Quantities

Parameter/Equipment	Range	CMC ^{2, 5} (±)	Comments
Gas Flow – Air & N2			
Laminar Flow	(0.01 to 50) slpm	0.20 %	Fluke Molbox standard
Sonic Flow	(10 to 120) slpm	0.20 %	

IV. Mechanical

Parameter/Equipment	Range	CMC ^{2, 5, 6} (±)	Comments
Vacuum ³ – Measure & Measuring Equipment	(1 to 30) in·Hg (3 to 500) psig	0.000 52 in·Hg + 0.000 16 in·Hg/in·Hg 0.0087 psi + 0.000 16 psi/psi	Fluke P3025-3-P

Parameter/Equipment	Range	CMC ^{2, 5, 6} ($\pm$)	Comments
Pressure ³ – Measure & Measuring Equipment			
Hydraulic	(400 to 10 000) psig	0.17 psi + 0.000 17 psi/psi	Pressurements W2200/3HP
Pneumatic	(4 to 200) ins H ₂ O @ 60 °F	0.008 in·H ₂ O + 0.000 27 in·H ₂ O/in·H ₂ O	Ametek PK II
Torque – Measure ³	(2.5 to 25) lb·in (25 to 75) lb·in (10 to 100) lb·ft (100 to 1000) lb·ft	0.20 lbf·in 0.60 lbf·in 1.2 % 1.2 %	Mountz BMX25i Jetco TED-75is-P Mountz LTT-100F Mountz BMX 1000F

V. Thermodynamic

Parameter/Equipment	Range	CMC ^{2, 6} ($\pm$)	Comments
Temperature – Measure & Measuring Equipment ³	(-197 to 420) °C (420 to 961) °C	0.027 °C + 0.000 017 °C/°C 0.014 °C + 0.000 097 °C/°C	2560 thermometer 5614 PRT 5624 PRT
Temperature – Measure ³	(10 to 38) °C	0.23 °C	Vaisala M170 with HMP77B
Dewpoint – Measuring Equipment	(-80 to < -50) °C (-50 to < 0) °C (0 to 20) °C	1.1 °C 0.18 °C 0.13 °C	Mitchell S8000RS chilled mirror hygrometer
Relative Humidity – Measuring Equipment	(10 to 95) % RH	0.67 % RH	Thunder Scientific 1200 humidity generator
Relative Humidity – Measure ³	(5 to 90) % RH	1.3 % RH	Vaisala M170 with HMP77B

VI. Time & Frequency

Parameter/Equipment	Range	CMC ^{2, 6} ($\pm$)	Comments
Frequency – Measuring Equipment ³	5 Hz to 10 MHz	0.29 μ Hz/Hz	Wavetek 9100, Fluke 5522A
Frequency – Measure ³	5 Hz to 225 MHz	0.29 μ Hz/Hz	HP 5334B

¹ This laboratory offers commercial calibration service.

² Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of $k = 2$. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.

³ Field calibration service is available for this calibration. Please note the actual measurement uncertainties achievable on a customer's site can normally be expected to be larger than the CMC found on the A2LA Scope. Allowance must be made for aspects such as the environment at the place of calibration and for other possible adverse effects such as those caused by transportation of the calibration equipment. The usual allowance for the actual uncertainty introduced by the item being calibrated, (e.g. resolution) must also be considered and this, on its own, could result in the actual measurement uncertainty achievable on a customer's site being larger than the CMC.

⁴ The measurands stated are generated using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure the measurand in the ranges indicated. CMCs are expressed as either a specific value that covers the full range or as a fraction of the reading plus a fixed floor specification.

⁵ In the statement of CMC, the value is defined as the percentage of reading; L is the numerical value of the nominal length of the device measured in inches, unless otherwise noted.

⁶ The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

⁷ This scope meets A2LA's *P112 Flexible Scope Policy*.



Accredited Laboratory

A2LA has accredited

TRESCAL, INC.

Providence Forge, VA

for technical competence in the field of

Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 15th day of August 2022.

A blue ink signature of Mr. Trace McInturff.

Mr. Trace McInturff, Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 1486.02
Valid to April 30, 2024
Revised September 7, 2023

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.